

## $\begin{array}{c} \textbf{NTE5620} \\ \textbf{TRIAC} \\ \textbf{800V}_{\textbf{RM}}, \, \textbf{8A}, \, \textbf{TO220} \, \, \textbf{Full Pack} \end{array}$

The NTE5620 TRIAC is designed primarily for full—wave AC control applications, such as light dimmers, heater controls, motor controls, and power supplies; or wherever full wave silicon gate controlled solid state devices are needed. TRIAC type thyristors switch from a blocking to a conducting state for either polarity of applied voltage with positive or negative gate triggering.

## Features:

- Blocking Voltage 800 Volts
- All Diffused and Glass Passivated Junctions for Greater Parameter Uniformity and Stability
- Small, Rugged, TO220 Full Pack for Low Thermal Resistance, High Heat Dissipation, and Durability
- Gate Triggering Guaranteed in Four Modes

## **Absolute Maximum Ratings:**

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Peak Repetitive Off–State Voltage, V <sub>DRM</sub>
$(T_J = -40^\circ \text{ to } +125^\circ \text{C}, 1/2 \text{ Sine Wave 50 to } 60\text{H}_Z, \text{ Gate Open, Note 1}) \dots 800\text{V}$
On–State Current RMS, $I_{T(RMS)}$ ( $T_C = +80^{\circ}C$ , Full Cycle Sine Wave 50 to $60H_Z$ , Note 2)
$(T_C = +80^{\circ}C, Full Cỳcle Sine Wave 50 to 60HZ, Note 2)$
Peak Non-Repetitive Surge Current, I <sub>TSM</sub>
(One Full Cycle, 60Hz, $T_C = +125$ °C, Preceded and followed by rated current) 100A
Peak Gate Power ( $T_C = +80^{\circ}C$ , Pulse Width = $2\mu$ s), $P_{GM}$
Average Gate Power ( $T_C = +80^{\circ}C$ , $t = 8.3$ ms), $P_{G(AV)}$
Peak Gate Current (Pulse Width = 2μs), I <sub>GM</sub> 4A
RMS Isolation Voltage ( $T_A = +25$ °C, Relative Humidity $\leq 20$ %), $V_{(ISO)}$
Operating Junction Temperature Range, T <sub>J</sub>
Storage Temperature Range, T <sub>stg</sub> –40° to +150°C
Thermal Resistance, Junction–to–Case, R <sub>thJC</sub>
Typical Thermal Resistance, Case–to–Sink, R <sub>thCS</sub>
Thermal Resistance, Junction–to–Ambient, R <sub>thJA</sub>

- Note 1. Ratings apply for open gate conditions. Thyristor devices shall not be tested with a constant current source for blocking capability such that the voltage applied exceeds the rated blocking voltage.
- Note 2. The case temperature reference point for all  $T_C$  measurements is a point on the center lead of the package as close as possible to the plastic body.

## $\underline{\textbf{Electrical Characteristics:}} \; (T_C = +25^{\circ} \text{C unless otherwise specified})$

Characteristics	Symbol	Min	Тур	Max	Unit
Peak Blocking Current (Either Direction) (Rated V <sub>DRM</sub> , T <sub>J</sub> = +125°C, Gate Open)	I <sub>DRM</sub>	_	_	2	mA
Peak On–State Voltage (Either Direction) (I <sub>TM</sub> = 11.3A Peak; Pulse Width = 1 to 2ms, Duty Cycle < 2%)	V <sub>TM</sub>	_	1.7	2.0	V
Peak Gate Trigger Current (Main Terminal Voltage = 12Vdc, R <sub>L</sub> = 100 Ohms) MT2(+), G(+) MT2(+), G(-) MT2(-), G(-) MT2(-), G(+)	I <sub>GT</sub>			50 50 50 75	mA
Peak Gate Trigger Voltage (Main Terminal Voltage = 12Vdc, $R_L$ = 100 Ohms) MT2(+), G(+) MT2(+), G(-) MT2(-), G(-) MT2(-), G(+) (Main Terminal Voltage = Rated $V_{DRM}$ , $R_L$ = 10k $\Omega$ , $T_J$ = +125°C) MT2(+), G(+); MT2(+), G(-); MT2(-), G(-) MT2(-), G(+)	V <sub>GT</sub>	- - - - - 0.2	0.9 0.9 1.1 1.4	2.0 2.0 2.0 2.5	V
Holding Current (Either Direction) (Main Terminal Voltage = 24Vdc, Gate Open I <sub>T</sub> = 200mA)	IH	_	_	50	mA
Critical Rate of Rise of Off–State Voltage (Rated V <sub>DRM</sub> , Exponential Waveform, T <sub>J</sub> = +125°C, Gate Open)	dv/dt	_	100	_	V/µs
Critical Rate of Rise of Commutation Voltage (Rated $V_{DRM}$ , $I_{T(RMS)}$ = 6A, Commutating di/dt = 4.3A/ms, Gate Unenergized, $T_{C}$ = +80°C)	dv/dt(c)	_	5		V/µs



